Angelica Chiodoni has completed her M. Sc. in Material Science (Università degli studi di Torino) in 2001 and her PhD in Physics in 2005 (Politecnico di Torino). She is an electron microscopist and a material scientist, working for over 19 years with scanning electron microscopy (FESEM), transmission electron microscopy (TEM) and focused ion beam (FIB) microscopy systems. Currently she is the PI of the "Advanced characterizations and optimized functional materials for energetic transition" research line at the Center for Sustainable Future Technologies (CSFT, Torino), ISTITUTO ITALIANO DI TECNOLOGIA.